Title	PCN Number:		20130627002					PCN Date: 07/16/2013		
intie	INA3221 Da	ta Sh	eet							
Customer Contact:		PCN	PCN Manager Phone: +1(214) 480-6037				7 Dept:	Quality Servic	es	
Char	nge Type:									
	Assembly Site		Asser	nbly Process			Assembly	y Materials		
Design			Electr	Electrical Specification			Mechanical Specification			
Test Site			_	Packing/Shipping/Labeling			Test Process			
Wafer Bump Site			_	Wafer Bump Material			Wafer Bump Process			
	Wafer Fab Site Wafer Fab Materials Wafer Fab Proce						b Process			
				PCN Details	\$					
Desc	cription of Chang	je:								
datas	ollowing change h sheet links provide Texas		/ provide:	s further details. Th	iese cha	ange	es may be	reviewed at the	9	
www.ti						SB	OS576A - MAY 20	012-REVISED JUNE 2013		
				REVISION HISTORY	,					
NOTE	E: Page numbers for p	revious	s revisions	may differ from page nu	umbers in	the	current versi	on.		
Chang	ges from Original (May	2012) t	o Revision	Α				Page		
Changed Input, Voltage input range, Shunt parameter specifications in +3.3 V Electrical Characteristics table										
• Up	nanged bit D15 in Power									
• Up • Ch		Valid U	pper Limit R	Register				28		
 Up Ch Ch 	nanged bit D15 in Power	Valid U Valid L	lpper Limit R ower Limit R							
 Up Ch Ch Ch 	nanged bit D15 in Power nanged second paragrap	Valid U Valid L oh of Se	lpper Limit R ower Limit R rial Bus Add	Register Register						
 Up Ch Ch Ch Up 	nanged bit D15 in Power nanged second paragrap odated Figure 29 and Fig	Valid U Valid L oh of Sei gure 30	lpper Limit R ower Limit R rial Bus Add	Register Register ress section				28 28 29 30		
 Up Ch Ch Ch Up Ch 	nanged bit D15 in Power nanged second paragrap odated Figure 29 and Fig nanged footnote 1 in Fig	Valid U Valid L oh of Se gure 30 ure 29 a	pper Limit R ower Limit R rial Bus Add nd Figure 3	Register Register ress section				28 28 29 30 30		
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Reason for Change:							
To more accurately reflect device characteristics							
Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):							
Electrical specification performance changes as indicated above.							
Changes to product identification resulting from this PCN:							
None							
Product Affected:							
INA3221AIRGVR INA3221AIRGVT							

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
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Asia Pacific	PCNAsiaContact@list.ti.com
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